Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	t(s)/Patent under nation
10/612,040	CHOI ET AL.	ΓAL.
Examiner	Art Unit	
Tianjie Chen	2652	

	SEARCHED				
Class	Subclass	Date	Examiner		
310	51	9/30/2005	TJ		

INTERFERENCE SEARCHED			
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